

# HCC4051B/52B/53B HCF4051B/52B/53B

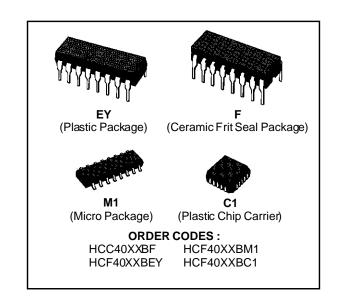
## ANALOG MULTIPLEXERS-DEMULTIPLEXERS

4051B - SINGLE 8-CHANNEL

4052B - DIFFERENTIAL 4-CHANNEL

4053B - TRIPLE 2-CHANNEL

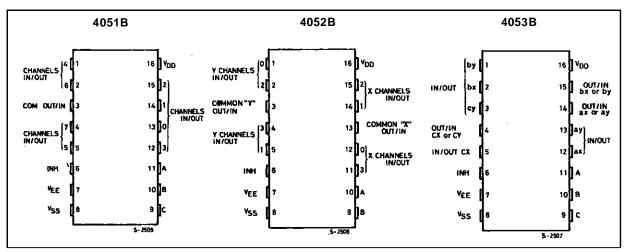
- QUIESCENT CURRENT SPECIFIED TO 20V FOR HCC DEVICE
- LOW "ON" RESISTANCE :  $125\Omega$  (typ.) OVER 15V p.p. SIGNAL-INPUT RANGE FOR VDD-VEE = 15V
- HIGH "OFF" RESISTANCE : CHANNEL LEAK-AGE ± 100pA (typ.) VDD - VEE = 18V
- BINARY ADDRESS DECODING ON CHIP
- VERY LOW QUIESCENT POWER DISSIPATION UNDER ALL DIGITAL CONTROL INPUT AND SUPPLY CONDITIONS : 0.2  $\mu$ W (typ.),  $V_{DD} V_{SS} = V_{DD} V_{EE} = 10V$
- MATCHED SWITCH CHARACTERISTICS :  $R_{ON} = 5\Omega$  (typ.) for  $V_{DD} V_{EE} = 15V$
- WIDE RANGE OF DIGITAL AND ANALOG SIG-NAL LEVELS: DIGITAL 3 TO 20V, ANALOG TO 20V p.p.
- 5V, 10V, AND 15V PARAMETRIC RATINGS
- INPUT CURRENT OF 100mA AT 18V AND 25°C FOR HCC DEVICE
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC TEN-TATIVE STANDARD N° 13A, "STANDARD SPECIFICATIONS FOR DESCRIPTION OF "B" SERIES CMOS DEVICES"



#### **DESCRIPTION**

The HCC 4051B, 4052B and 4053B (extended temperature range) and HCF4051B, 4052B and 4053B (intermediate temperature range) are monolithic integrated circuits, available in 16-lead dual in-line plastic or ceramic package and plastic micropackage. HCC/HCF4051B, HCC/HCF4052B, and HCC/HCF4053B analog multiplexers/demultiplexers are digitally controlled analog switches having low ON impedance and very low OFF leakage

#### **PIN CONNECTIONS**

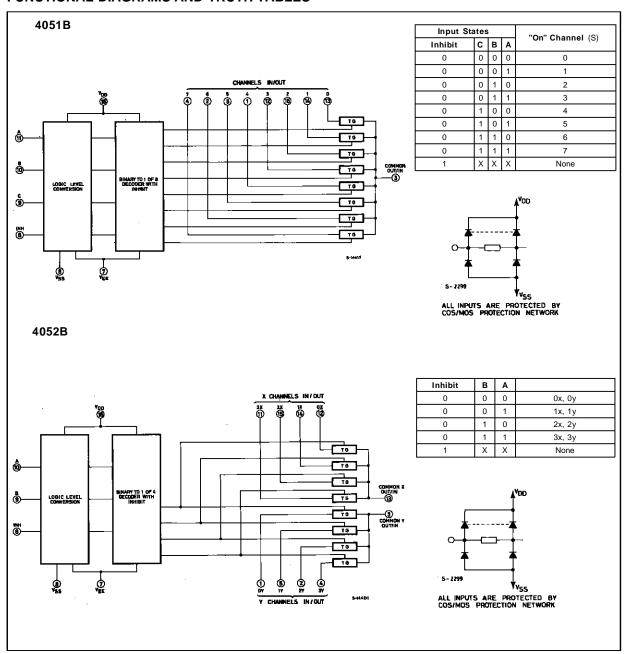


June 1989 1/17

current. These multiplexer circuits dissipate extremely low quiescent power over the full  $V_{DD}-V_{SS}$  and  $V_{DD}-V_{EE}$  supply-voltage ranges, independent of the logic state of the control signals. When a-logic "1" is present at the inhibit input terminal all channel are off. The **HCC/HCF4051B** is a single 8-channel multiplexer having three binary control inputs, A, B, and C, and an inhibit input. The three binary signals select 1 of 8 channels to be turned on, and connect one of the 8 inputs to the output. The **HCC/HCF4052B** is a differential 4-channel multi-

plexer having two binary control inputs, A and B, and an inhibit input. The two binary input signals select 1 of 4 pairs of channels to be turned on and connect the analog inputs to the outputs. The **HCC/HCF4053B** is a triple 2-channel multiplexer having three separate digital control inputs, A, B, and C, and an inhibit input. Each control input selects one of a pair of channels which are connected in a singlepole double-throw configuration.

#### **FUNCTIONAL DIAGRAMS AND TRUTH TABLES**



2/17

### 4053 A or B or C Inhibit 0 0 ax or bx or cx 0 1 ay or by or cy Χ None X = Don't care. IN/QUT LOGIC LEVEL рх (2) ð (3) ô **V<sub>A</sub>D**D (9) ALL INPUTS ARE PROTECTED BY COS/MOS PROTECTION NETWORK Q

#### FUNCTIONAL DIAGRAMS AND TRUTH TABLES (continued)

#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>DD</sub> *	Supply Voltage : HCC Types	- 0.5 to + 20	V
	<b>HCF</b> Types	- 0.5 to + 18	V
$V_{i}$	Input Voltage	- 0.5 to V <sub>DD</sub> + 0.5	V
I <sub>I</sub>	DC Input Current (any one input)	± 10	mA
$P_{tot}$	Total Power Dissipation (per package) Dissipation per Output Transistor	200	mW
	for T <sub>op</sub> = Full Package-temperature Range	100	mW
Top	Operating Temperature : HCC Types	- 55 to + 125	°C
·	HCF Types	- 40 to + 85	°C
$T_{stg}$	Storage Temperature	- 65 to + 150	°C

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for external periods may affect device reliability.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Value	Unit
$V_{DD}$	Supply Voltage : HCC Types HCF Types	3 to 18 3 to 15	V V
$V_{I}$	Input Voltage	0 to V <sub>DD</sub>	V
Top	Operating Temperature : <b>HCC</b> Types <b>HCF</b> Types	- 55 to + 125 - 40 to + 85	°C ℃



<sup>\*</sup> All voltage values are referred to V<sub>SS</sub> pin voltage.

### STATIC ELECTRICAL CHARACTERISTICS (over recommended operating conditions)

			Tes	t Con	dition	<u>s</u>				Value				
Symbol	Parame	tor	V <sub>IS</sub>	V <sub>EE</sub>	V <sub>SS</sub>	V <sub>DD</sub>	Т.	* ow		25 °C		T <sub>High</sub> *		Unit
Syllibol	Faranie	itei	(V)	(V)	(V)	(V)	Min.	Max.	Min.		Max.	Min.		Ollit
IL.	Quiescent	1	( V )	( v )	( )	5	IVIIII.	5 5	IVIIII.	0.04	5	IVIIII.	<b>Max.</b> 150	
'L		нсс				10		10		0.04	10		300	
	Device	1				15		20		0.04	20		600	
	Current	Types				20		100		0.08	100		3000	
						5		20		0.04	20		150	μΑ
		HCF				10		40		0.04	40		300	
		Types				15		80		0.04	80		600	
SWITC	Н									0.0 1	- 00			
ON	Resistance		0 ≤ V <sub>1</sub>			5		880		470	1050		1200	
		HCC	≤ V <sub>DD</sub>	0	0	10		310		180	400		580	
		Types	00			15		220		125	280		400	
			0 ≤ V <sub>I</sub>			5		880		470	1050		1200	Ω
		HCF	≤ V <sub>DD</sub>	0	0	10		330		180	400		520	
		Types	_ V DD			15		230		125	280		360	
ΔΟΝ	Resistance /	\R <sub>ON</sub>				5				10				
	(between a			0	0	10				10				Ω
	channels)	11y Z				15				5				
OFF (•)	Any	1							<b>-</b>	<u> </u>				
		нсс		0	0	40		400		1, , ,	100		1000	^
Channel	Channel	Types		U	0	18		100		± 0.1	100		1000	nA
Leakage	OFF	1 9 000												
Current	All													
	Channels	нсс												
	OFF			0	0	18		100		± 0.1	100		1000	nA
	(common	Types			~	'Ŭ		'''		l - 0. i	100		1000	'''`
	OUT/IN)													
									<b>-</b>					
	Any	HCF		0	0	15		200		1, , ,	200		1000	^
	Channel	Types		U	0	15		300		± 0.1	300		1000	nA
	OFF	Турсз												
	All													
	Channels	HCF												
	OFF	1		0	0	15		300		± 0.1	300		1000	nA
	(common	Types				'Ŭ		000		- 0				
	OUT/IN)													
С	Input	1								5				
Capaci	Output 405	1								30				
	Output 405		1							18				pF
tance	Output 405	<u>2</u> 3	1	- 5	- 5	5				9				
	Feedthroug		1							0.2				
CONTR	OL (Address	or Inhil	nit)		l				I	0.2		l	1	
V <sub>IL</sub>	Input Low V		$= V_{DD}$	V <sub>E</sub> =	- V <sub>SS</sub>	5		1.5	1	1	1.5		1.5	
· IL		J90	Thru	R. –	1ΚΩ	10		3			3		3	v
			1ΚΩ			15		4			4		4	·
			11/77	to \		5	3.5	<u> </u>	3.5		<u> </u>	3.5		
V <sub>IH</sub>	Input High \	/oltage	1	I <sub>IS</sub> <	2μΑ	10	7		7			7		
- 117					all off	15	11		11			11		V
				chan	nels)									
I <sub>IH</sub> , I <sub>IL</sub>	Input HCC		V <sub>I</sub> =	0/18\	/	10		± 0.1		±10 <sup>-3</sup>	± 0 1		± 1	
	Leakage	Types				18		± 0. i		±10	± 0.1		エ	
	Current	HCF	V <sub>1</sub> =	0/15\	/	4-			İ	. 40-3		İ	l	μΑ
	Janon	Types	',-	· • •		15		± 0.3		±10 <sup>-3</sup>	± 0.3		± 1	
Cı			Any Add	ress o	r Inhih	it				5	7.5			pF
	I II Put Capac	ntai ioo	-	.000 0						ľ	′.5			ן יי
		Input					<u> </u>	L	<u> </u>	l	<u> </u>	1		

<sup>(•)</sup> Determined by minimum feasible leakage measurement for automatic testing. (\*)  $T_{Low} = -55^{\circ}C$  for **HCC** device :  $-40^{\circ}C$  for **HCF** device. (\*)  $T_{High} = +125^{\circ}C$  for **HCC** device :  $+85^{\circ}C$  for **HCF** device.

### DYNAMIC ELECTRICAL CHARACTERISTICS

 $(T_{amb} = 25^{\circ}C, C_{L} = 50 pF \text{ all input square wave rise and fall time} = 20 ns)$ 

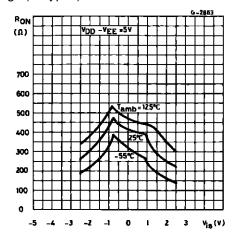
	Test Conditions Va					Va	lue				
Parameter	V <sub>EE</sub>	RL	fi	V <sub>IS</sub>	V <sub>SS</sub>	<b>V</b> <sub>DD</sub>			Тур.	Max.	Unit
CWITCH	(V)	(kΩ)	(kHz)	(V)	(V)	(V)					
SWITCH			Ι	10.1/					20	20	
t <sub>pd</sub> Propagation Delay Time (signal input to output)		000		10 V		5			30 15	30	
(Signal Input to output)		200		<b>1</b>		10 15			11	60 20	ns
Frequency Response	- \/.	1		E /s\		10	V <sub>o</sub> at Common	4053B	30	20	
Channel "ON" (sine wave	= V <sub>SS</sub>	'		5 (•)		10	OUT/IN	4053B 4052B	25		-
input)							0017111	4052B 4051B	20		MHz
at 20 Log $\frac{V_0}{V_1} = -3dB$							V <sub>o</sub> at any Channe		60		1
V								'			
Feedthrough (all channels	$= V_{SS}$	1		5 (•)		10	V <sub>o</sub> at Common	4053	8		
OFF)							OUT/IN	4052	10		MHz
at 20 Log $\frac{V_0}{V_1} = -40 \text{dB}$								4051	12		171112
• 1							V <sub>o</sub> at any Channe		8		
Frequency Signal Crosstalk							Between any 2 Ch		3		
at 20 Log $\frac{V_o}{V_l} = -40 \text{dB}$	$= V_{SS}$	1		5 (•)		10	Between Sections		6		
V <sub>I</sub>							4052B only	on			MHz
								common	40		-
								measured on any	10		
								channel			
							Between any 2	in Pin 2	2.5		
							Sections 4053B	out Pin 14	=.0		MHz
							only	in Pin 15	6		1 1 1 1 1 2
								out Pin 14			
Sine Wave Distortion	= V <sub>SS</sub>	10	1	2 (•)		5			0.3		
f <sub>is</sub> = 1kHz Sine Wave		10	1	3 (•)		10			0.2		%
		10	1	5 (•)		15			0.12		
CONTROL (Address or Inh	ibit)										
Progation Delay Time:	0				0	5			360	720	
Address-to Signal OUT	0				0	10			160	320	ns
Channels ON or OFF	0				0	15			120	240	1113
	- 5				0	5			225	450	
Propagation Delay Time:	0				0	5			360	720	
Inhibit to Signal OUT	0	10			0	10			160	320	ns
(channel turning ON)	0	10			0	15			120	240	'''
	- 10				0	5			200	400	
Propagation Delay Time :	0					5			200	450	1
Inhibit to Signal OUT	0	0.3				10			90	210	ns
(channel turning OFF)	0	0.0				15			70	160	''3
	- 10					5			130	300	
Address or Inhibit to Signal	0	10*			0	10	$V_C = V_{DD} - V_{SS}$ (so	quare	65		mV
Crosstalk							wave)				peak

<sup>(●)</sup> Peak to peak voltage symmetrical about VDD-VEE

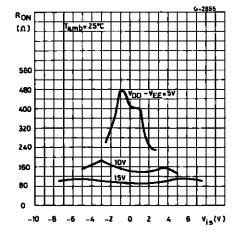


<sup>(\*)</sup> Both ends of channel.

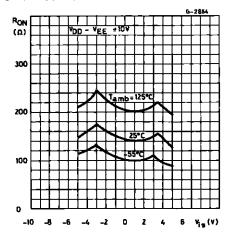
Typical Channel ON Resistance vs. Input Signal Voltage (all types).



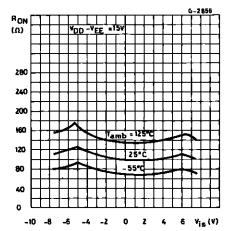
Typical Channel ON Resistance vs. Input Signal Voltage (all types).



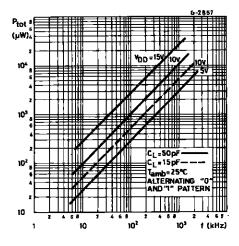
Typical Channel ON Resistance vs. Input Signal Voltage (all types).

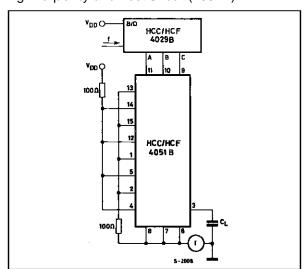


Typical Channel ON Resistance vs. Input Signal Voltage (all types).

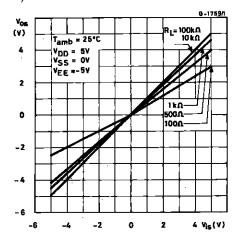


Typical Dynamic Power Dissipation/Package vs. Switching Frequency and Test Circuit (4051B).

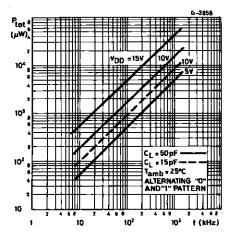


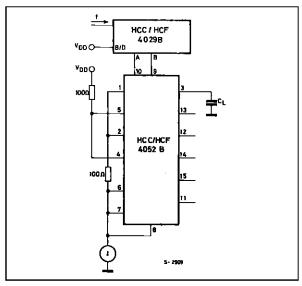


Typical ON Characteristics for 1 of 8 Channels (4051B).

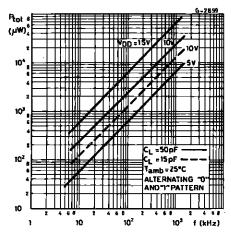


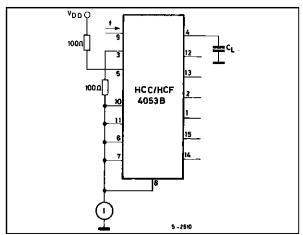
Typical Dynamic Power Dissipation/Package vs. Switching Frequency and Test Circuit (4052B).





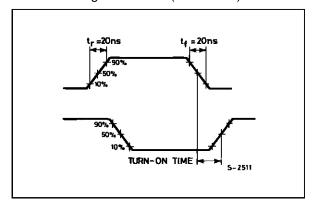
Typical Dynamic Power Dissipation/Package vs. Switching Frequency and Test Circuit (4053B).



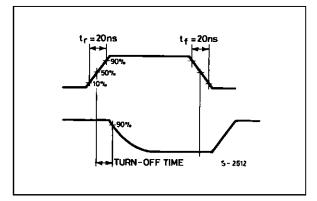


#### **WAVEFORMS**

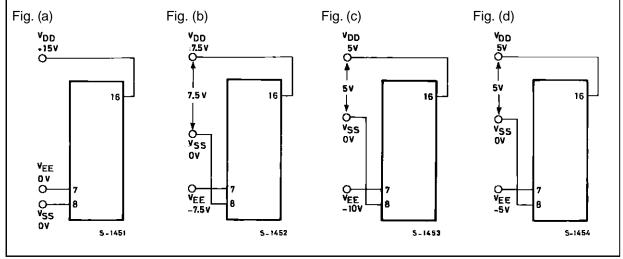
Channel Being Turned ON ( $R_L = 10K\Omega$ ).



Channel Being Turned OFF ( $R_L = 300 \text{K}\Omega$ ).



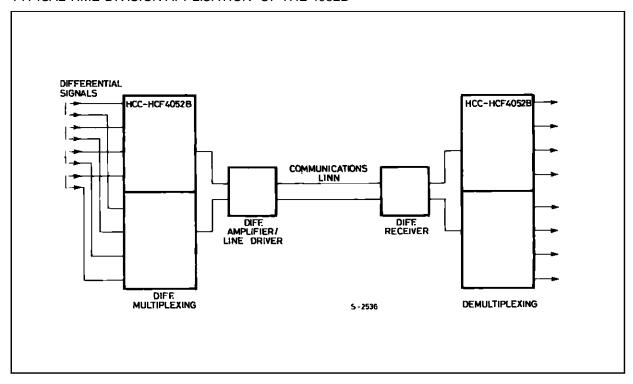
#### **TYPICAL BIAS VOLTAGES**



The ADDRESS (digital-control inputs) and INHIBIT logic levels are : "0"= $V_{SS}$  and "1"= $V_{DD}$ . The analog signal (trough the TG) may swing from  $V_{EE}$  to  $V_{DD}$ .

#### TYPICAL APPLICATIONS

TYPICAL TIME-DIVISION APPLICATION OF THE 4052B



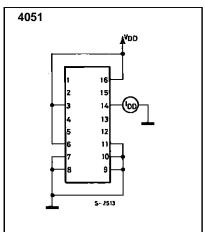
#### SPECIAL CONSIDERATIONS

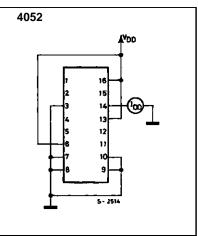
Control of analog signals up to 20V peak-to-peak can be achieved by digital signal amplitudes of 4.5 to 20V (if  $V_{DD} - V_{SS} = 3V$ , a  $V_{DD} - V_{EE}$  of up to 13V can be controlled; for  $V_{DD} - V_{EE}$  level differences above 13V, a  $V_{DD} - V_{SS}$  of at least 4.5V is required). For example, if  $V_{DD} = +5V$ ,  $V_{SS} = 0$ , and  $V_{EE} = -13.5V$ , analog signals from -13.5V to +4.5V can be controlled by digital inputs of 0 to 4.5V. In certain applications, the external load-resistor current may include both  $V_{DD}$  and signal-line components. To

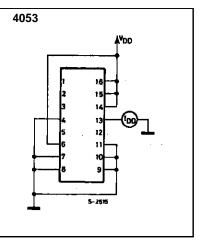
avoid drawing  $V_{DD}$  current when switch current flows into the transmission gate inputs, the voltage drop across the bidirectional switch must not exceed 0,8 volt (valvulated from  $R_{ON}$  values shown in ELECTRICAL CHARACTERISTICS CHART). No  $V_{DD}$  current will flow through  $R_L$  if the switch current flows into lead 3 on the **HCC/HCF4051**; leads 3 and 13 on the **HCC/HCF4053**.

#### **TEST CIRCUITS**

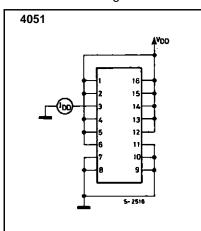
Off Channel Leakage Current-any Channel OFF.

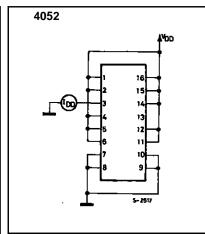


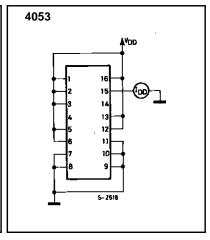




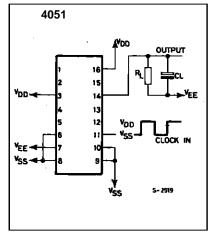
Off Channel Leakage Current-all Channel OFF.

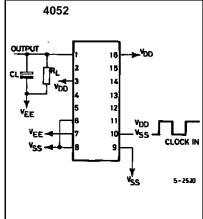


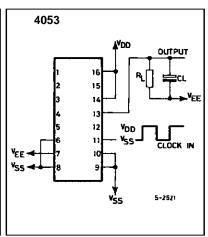




Propagation Delay-adress Input to Signal Output.

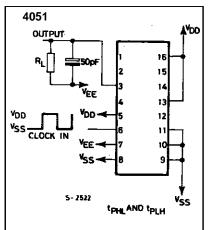


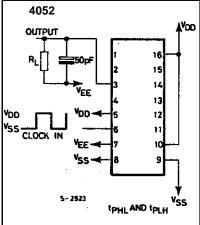


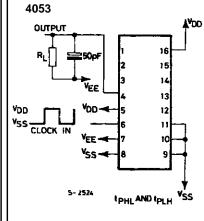


#### **TEST CIRCUITS** (continued)

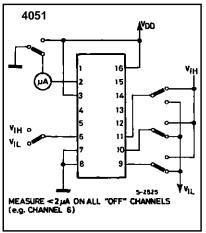
Propagation Delay-Inhibit Input to Signal Output.

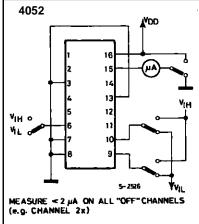


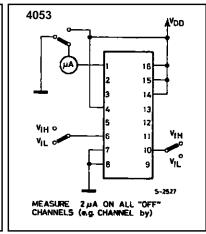




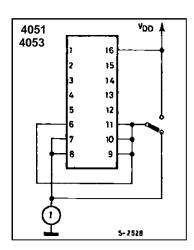
Input Voltage.

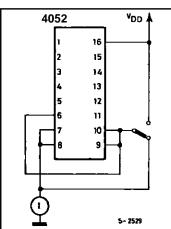




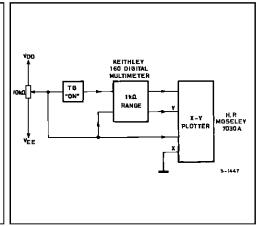


Quiescent Device Current.



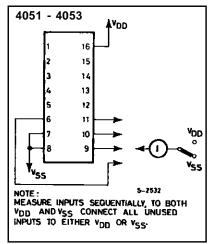


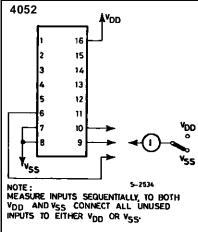
Channel ON Resistance Meaurement Circuit.



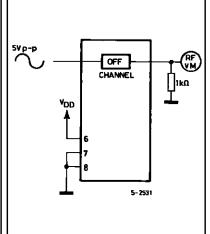
#### **TEST CIRCUITS** (continued)

Input Current.

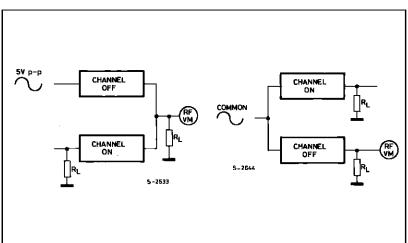




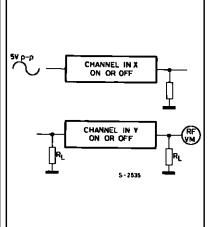
Feedthrough (All Types).



Crosstalk Betwen any two Channels (All Types).

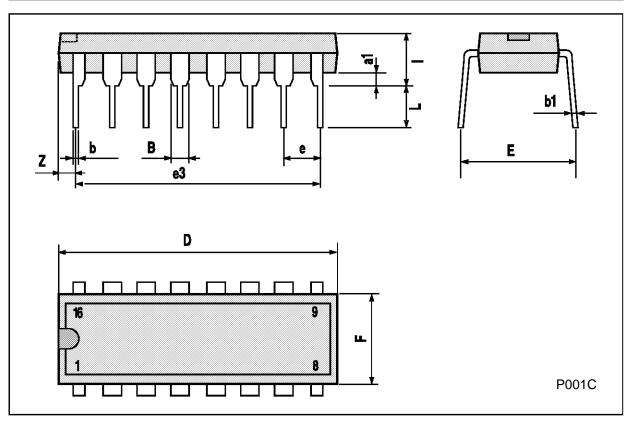


Crosstalk Betweenn Duals or Triplets (4052-4053).



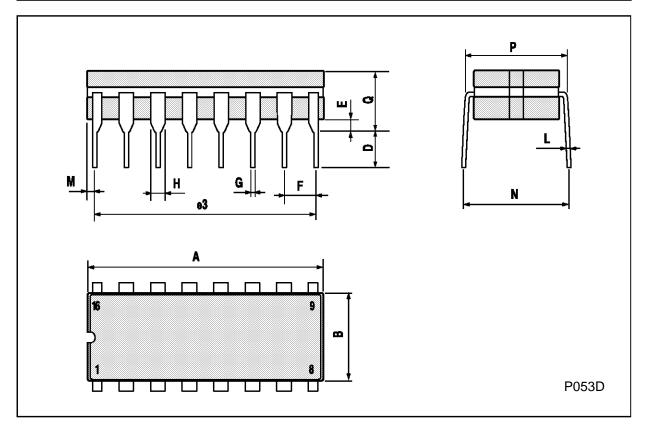
# Plastic DIP16 (0.25) MECHANICAL DATA

DIM.		mm		inch				
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
a1	0.51			0.020				
В	0.77		1.65	0.030		0.065		
b		0.5			0.020			
b1		0.25			0.010			
D			20			0.787		
E		8.5			0.335			
е		2.54			0.100			
e3		17.78			0.700			
F			7.1			0.280		
ı			5.1	_		0.201		
L		3.3			0.130			
Z			1.27			0.050		



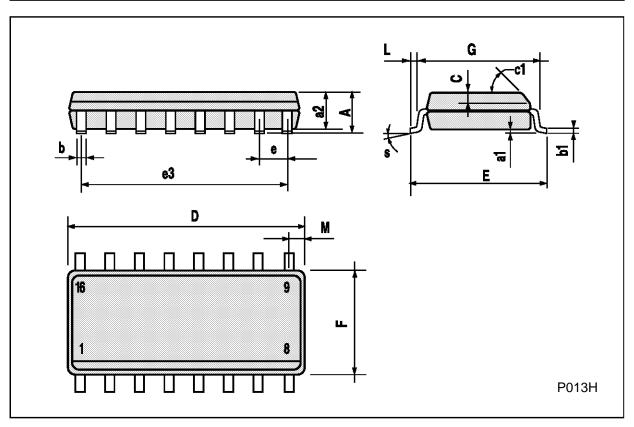
## **Ceramic DIP16/1 MECHANICAL DATA**

DIM.		mm		inch				
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
А			20			0.787		
В			7			0.276		
D		3.3			0.130			
Е	0.38			0.015				
e3		17.78			0.700			
F	2.29		2.79	0.090		0.110		
G	0.4		0.55	0.016		0.022		
Н	1.17		1.52	0.046		0.060		
L	0.22		0.31	0.009		0.012		
М	0.51		1.27	0.020		0.050		
N			10.3			0.406		
Р	7.8		8.05	0.307		0.317		
Q			5.08			0.200		



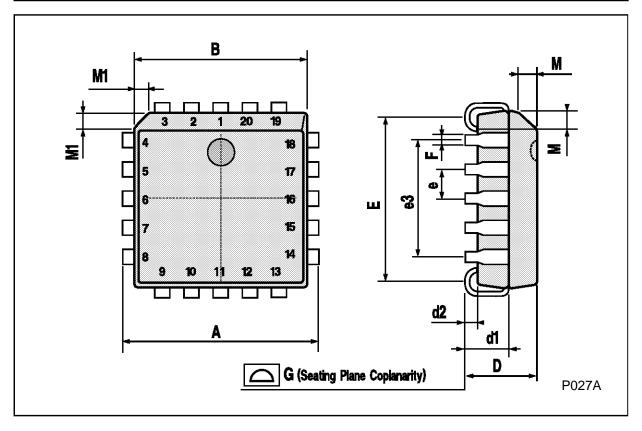
# SO16 (Narrow) MECHANICAL DATA

DIM.		mm		inch							
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.					
А			1.75			0.068					
a1	0.1		0.2	0.004		0.007					
a2			1.65			0.064					
b	0.35		0.46	0.013		0.018					
b1	0.19		0.25	0.007		0.010					
С		0.5			0.019						
c1			45°	(typ.)							
D	9.8		10	0.385		0.393					
Е	5.8		6.2	0.228		0.244					
е		1.27			0.050						
e3		8.89			0.350						
F	3.8		4.0	0.149		0.157					
G	4.6		5.3	0.181		0.208					
L	0.5		1.27	0.019		0.050					
М			0.62			0.024					
S		8° (max.)									



## PLCC20 MECHANICAL DATA

DIM.		mm		inch			
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	9.78		10.03	0.385		0.395	
В	8.89		9.04	0.350		0.356	
D	4.2		4.57	0.165		0.180	
d1		2.54			0.100		
d2		0.56			0.022		
E	7.37		8.38	0.290		0.330	
е		1.27			0.050		
e3		5.08			0.200		
F		0.38			0.015		
G			0.101			0.004	
М		1.27			0.050		
M1		1.14			0.045		



Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsability for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may results from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectonics.

© 1994 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES

Australia - Brazil - France - Germany - Hong Kong - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A

